Index of Claims 10517250 Examiner David Q Nguyen Applicant(s)/Patent Under Reexamination GORTZ ET AL. Art Unit 2617

✓	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
=	Allowed	÷	Restricted	I	Interference	0	Objected

		in the same order		DATE			
CL			 	DATE			
Final	Original	03/31/2008					
	1	✓					
	2	✓					
	3	✓					
	4	✓					
	5	✓					
	6	✓					
	7	✓					
	8	-					
	9	√					
	10	√					
	11	✓					
	12	✓					
	13	N					
	14	√					
	15	✓					
	16	N					1
	17	√					
	18	√					1
	19	√					
	20	√					
	21	✓					
	22	√					
	23	√					
	24	√					†
	25	√	1				+
	26	√					†
	27	√					+
	28	✓					+
	29	√					+
	30	N					+
	31	N	+				+
	32	N					+
	33	N	+				+
	34	N					+
	35	N					+
	36	N				-	+

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✓	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
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CL	AIM			DATE		
Final	Original	03/31/2008				
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	68	N				
	69	N				
	70	N				
	71	N				

	Application/Control No.	Applicant(s)/Patent Under Reexamination
Index of Claims	10517250	GORTZ ET AL.
	Examiner	Art Unit
	David Q Nguyen	2617

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	Claims re	enumbered	in the sar	me o	rder as pr	esented by a	pplicant			□ СРА] T.C). [R.1.47		
	CLA	IM		DATE												
Fi	nal	Original	03/31/20	08												
		73	N													
		74	N													
		75	N													
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